

Current Transducer HO-S/SP30 series and HO 200-S/SP31

 I_{PN} = 50, 100, 150, 200, 250 A

HO 50-S/SP30, HO 100-S/SP30, HO 150-S/SP30, HO 200-S/SP30, Ref: HO 250-S/SP30 and HO 200-S/SP31

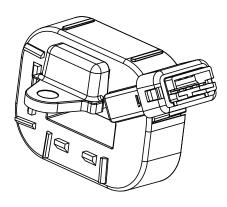
For the electronic measurement of current: DC, AC, pulsed..., with galvanic separation between the primary and the secondary circuit.











Features

- · Open loop multi-range current transducer
- Voltage output
- Single power supply +5 V
- Overcurrent detect 2.93 × I_{PN} (peak value)
- Galvanic separation between primary and secondary circuit
- Low power consumption
- · Compact design for panel mounting
- Aperture: 15 × 8 mm
- · Factory calibrated
- Connection mating with JST:
 - housing PHR-5
 - contact SPH-00xT
- · Repositionable mounting foot
- · Dedicated parameter settings available on request (see page 12).

Special feature

• Pre-mounted fixation foot, busbar configuration.

Advantages

- Low offset drift
- Over-drivable V_{ref}
- 8 mm creepage /clearance

- Fast response
- Low profile 2 mm pitch connector for 24 to 32 AWG wire.

Applications

- AC variable speed and servo motor drives
- · Static converters for DC motor drives
- Battery supplied applications
- Uninterruptible Power Supplies (UPS)
- Switched Mode Power Supplies (SMPS)
- Power supplies for welding applications
- Combiner box
- MPPT.

Standards

- IEC 61800-1: 1997
- IEC 61800-2: 2015
- IEC 61800-3: 2004
- IEC 61800-5-1: 2007
- IEC 62109-1: 2010
- UL 508: 2013.

Application Domain

• Industrial.

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Absolute maximum ratings

Parameter	Symbol	Unit	Value
Supply voltage (not destructive)	U _c	V	8
Supply voltage (not entering non standard modes)	U _c	V	6.5
Primary conductor temperature	$T_{_{\mathrm{B}}}$	°C	120
Electrostatic discharge voltage	U _{ESD}	kV	2

Stresses above these ratings may cause permanent damage. Exposure to absolute maximum ratings for extended periods may degrade reliability.

UL 508: Ratings and assumptions of certification

File # E189713 Volume: 2 Section: 5

Standards

- CSA C22.2 NO. 14-10 INDUSTRIAL CONTROL EQUIPMENT Edition 12
- UL 508 STANDARD FOR INDUSTRIAL CONTROL EQUIPMENT Edition 17

Ratings

Parameter	Symbol	Unit	Value
Primary involved potential		V AC/DC	600
Max surrounding air temperature	T_{A}	°C	105
Primary current	$I_{\scriptscriptstyle{ m P}}$	А	According to series primary current
Secondary supply voltage	U _c	V DC	5
Output voltage	$V_{ m out}$	V	0 to 5

Conditions of acceptability

- 1 These devices have been evaluated for overvoltage category III and for use in pollution degree 2 environment.
- 2 A suitable enclosure shall be provided in the end-use application.
- 3 The terminals have not been evaluated for field wiring.
- 5 Primary terminals shall not be straightened since assembly of housing case depends upon bending of the terminals.
- 6 Any surface of polymeric housing have not been evaluated as insulating barrier.
- 7 Low voltage control circuit shall be supplied by an isolating source (such as a transformer, optical isolator, limiting impedance or electro-mechanical relay).

Marking

Only those products bearing the UR Mark should be considered to be Listed or Recognized and covered under UL's Follow-Up Service. Always look for the Mark on the product.



Insulation coordination

Parameter	Symbol	Unit	Value	Comment
RMS voltage for AC insulation test 50/60 Hz/1 min	U _d	kV	4.3	
Impulse withstand voltage 1.2/50 μs	Û _w	kV	8	
Partial discharge test voltage (adjusted $q_{\rm m}$ < 10 pC)	U _t	V	> 1200	Busbar / Secondary
Clearance (pri sec.)	d _{CI}	mm	> 8	Shortest distance through air
Creepage distance (pri sec.)	d _{Cp}	mm	> 8	Shortest path along device body
Clearance (pri sec.)	-	mm	> 8	When mounted on PCB with recommended layout
Case material	-	-	V0 according to UL 94	
Comparative tracking index	CTI		600	
Application example	-	-	600 V CAT III PD2	Reinforced insulation according to IEC 61800-5-1
Application example	-	-	1000 V CAT III PD2	Basic insulation according to IEC 61800-5-1

Environmental and mechanical characteristics

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Ambient operating temperature	T_{A}	°C	-40		105	
Ambient storage temperature	$T_{\rm s}$	°C	-40		105	
Mass	т	g		32		



Electrical data HO 50-S/SP30-0100

At $T_{\rm A}$ = 25 °C, $U_{\rm C}$ = +5 V, $R_{\rm L}$ = 10 k Ω unless otherwise noted (see Min, Max, typ. definition paragraph in page 12).

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal RMS current	$I_{\scriptscriptstyle{PN}}$	А		50		
Primary current, measuring range	$I_{_{\mathrm{PM}}}$	А	-125		125	@ U _c ≥ 4.6 V
Number of primary turns	N _P	-		1		See application information
Supply voltage	$U_{\rm c}$	V	4.5	5	5.5	
Current consumption	$I_{\scriptscriptstyle m C}$	mA		19	25	
Reference voltage (output)	V _{ref}	V	2.48	2.5	2.52	Internal reference
Reference voltage (input)	V_{ref}	V	0.5		2.65	External reference
Output voltage range @ $I_{\scriptscriptstyle{\mathrm{PM}}}$	V _{out} - V _{ref}	V	-2		2	Over operating temperature range
V _{ref} output resistance	R_{ref}	Ω	130	200	300	Series
V _{out} output resistance	R _{out}	Ω		2	5	Series
Allowed capacitive load	C _L	nF	0		6	
Overcurrent detection output on resistance	$R_{\scriptscriptstyle ext{on}}$	Ω	70	95	150	Open drain, active low Over operating temperature range
Overcurrent detection hold	t_{hold}	ms	0.7	1	1.4	Additional time after threshold has released
EEPROM control	$V_{\rm out}$	mV	0		50	V _{out} forced to GND when EEPROM in an error state ¹⁾
Electrical offset voltage @ I_P = 0 A	V _{OE}	mV	-5		5	$V_{\text{out}} - V_{\text{ref}} @ V_{\text{ref}} = 2.5 \text{ V}$
Electrical offset current referred to primary	I_{OE}	А	-0.3125		0.3125	
Temperature coefficient of $V_{_{\mathrm{ref}}}$	TCV _{ref}	ppm/K	-170		170	−40 °C 105 °C
Temperature coefficient of V_{OE}	TCV _{OE}	mV/K	-0.075		0.075	−40 °C 105 °C
Offset drift referred to primary @ $I_p = 0$ A	TCI _{OE}	mA/K	-4.69		4.69	-40 °C 105 °C
Theoretical sensitivity	G_{th}	mV/A		16		800 mV @ I _{PN}
Sensitivity error @ $I_{\rm PN}$	ε _G	%	-0.5		0.5	Factory adjustment (straight bus-bar)
Temperature coefficient of G	TCG	ppm/K	-350		350	−40 °C 105 °C
Linearity error 0 \dots $I_{\rm PN}$	\mathcal{E}_{L}	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-0.75		0.75	
Linearity error 0 $I_{\scriptscriptstyle{\mathrm{PM}}}$	\mathcal{E}_{\llcorner}	% of $I_{\scriptscriptstyle{\mathrm{PM}}}$	-0.5		0.5	
Magnetic offset current (@ $10 \times I_{PN}$) referred to primary	I_{OM}	А	-0.92		0.92	One turn
Reaction time @ 10 % of $I_{\scriptscriptstyle \mathrm{PN}}$	t _{ra}	μs			2.5	@ 50 A/µs
Response time @ 90 % of $I_{\scriptscriptstyle \mathrm{PN}}$	t _r	μs			3.5	@ 50 A/µs
Frequency bandwidth (-3 dB)	BW	kHz		100		Small signals
Output RMS noise voltage spectral density (100 Hz 100 kHz)	e _{no}	μV/√ Hz			10.2	
Output noise voltage (DC 10 kHz) (DC 100 kHz) (DC 1 MHz)	V _{no}	mVpp		5.6 16.3 30.6		
Primary current, detection threshold	$I_{ m PTh}$	Α	2.64 × I _{PN}	2.93 × I _{PN}	3.22 × I _{PN}	Peak value ±10 %, overcurrent detection OCD
Accuracy @ I_{PN}	Х	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-1.25		1.25	
Accuracy @ I_{PN} @ T_A = +105 °C	Х	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-4.80		4.80	See formula note 2)
Accuracy @ I _{PN} @ T _A = +85 °C	Х	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-3.91		3.91	See formula note 2)

Notes: 1) EEPROM in an error state makes the transducer behave like a reverse current saturation. Use of the OCD may help to differentiate the two cases.

differentiate the two cases. ²⁾ Accuracy @ T_A (% of I_{PN}) = X + ($\frac{TCG}{10000}$ × (T_A -25) + $\frac{TCI_{OE}}{1000 \times I_{PN}}$ × 100 × (T_A -25)).



Electrical data HO 100-S/SP30-0100

At $T_{\rm A}$ = 25 °C, $U_{\rm C}$ = +5 V, $R_{\rm L}$ = 10 k Ω unless otherwise noted (see Min, Max, typ. definition paragraph in page 12).

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal RMS current	I_{PN}	А		100		
Primary current, measuring range	$I_{\scriptscriptstyle{PM}}$	А	-250		250	@ U _c ≥ 4.6 V
Number of primary turns	N _P	-		1		See application information
Supply voltage	U _c	V	4.5	5	5.5	
Current consumption	$I_{\rm c}$	mA		19	25	
Reference voltage (output)	V_{ref}	V	2.48	2.5	2.52	Internal reference
Reference voltage (input)	V_{ref}	V	0.5		2.65	External reference
Output voltage range @ $I_{\scriptscriptstyle{\mathrm{PM}}}$	V _{out} - V _{ref}	V	-2		2	Over operating temperature range
V _{ref} output resistance	R_{ref}	Ω	130	200	300	Series
V _{out} output resistance	R _{out}	Ω		2	5	Series
Allowed capacitive load	C _L	nF	0		6	
Overcurrent detection output on resistance	R _{on}	Ω	70	95	150	Open drain, active low Over operating temperature range
Overcurrent detection hold	t_{hold}	ms	0.7	1	1.4	Additional time after threshold has released
EEPROM control	V _{out}	mV	0		50	V _{out} forced to GND when EEPROM in an error state ¹⁾
Electrical offset voltage @ I_P = 0 A	V _{OE}	mV	-5		5	$V_{\text{out}} - V_{\text{ref}} \bigcirc V_{\text{ref}} = 2.5 \text{ V}$
Electrical offset current referred to primary	I_{OE}	А	-0.625		0.625	
Temperature coefficient of V_{ref}	TCV _{ref}	ppm/K	-170		170	−40 °C 105 °C
Temperature coefficient of V_{OE}	TCV _{OE}	mV/K	-0.075		0.075	−40 °C 105 °C
Offset drift referred to primary @ $I_P = 0$ A	TCI _{OE}	mA/K	-9.375		9.375	−40 °C 105 °C
Theoretical sensitivity	G_{th}	mV/A		8		800 mV @ I _{PN}
Sensitivity error @ $I_{\rm PN}$	$\boldsymbol{\mathcal{E}}_{G}$	%	-0.5		0.5	Factory adjustment (straight bus bar)
Temperature coefficient of G	TCG	ppm/K	-350		350	−40 °C 105 °C
Linearity error 0 \dots $I_{\rm PN}$	$\mathcal{E}_{oldsymbol{oldsymbol{arepsilon}}}$	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-0.5		0.5	
Linearity error 0 \dots $I_{\rm PM}$	$\mathcal{E}_{oldsymbol{oldsymbol{arepsilon}}}$	% of $I_{\scriptscriptstyle{\mathrm{PM}}}$	-0.5		0.5	
Magnetic offset current (@ 10 × $I_{\rm PN}$) referred to primary	$I_{\scriptscriptstyle{OM}}$	А	-0.92		0.92	One turn
Reaction time @ 10 % of $I_{\scriptscriptstyle \mathrm{PN}}$	t _{ra}	μs			2.5	@ 50 A/µs
Response time @ 90 % of $I_{\rm PN}$	t _r	μs			3.5	@ 50 A/µs
Frequency bandwidth (-3 dB)	BW	kHz		100		Small signals
Output RMS noise voltage spectral density (100 Hz 100 kHz)	e _{no}	μV/√ Hz			6	
Output noise voltage (DC 10 kHz) (DC 100 kHz) (DC 1 MHz)	V _{no}	mVpp		3.6 8.7 16.9		
Primary current, detection threshold	$I_{ m PTh}$	А	2.64 × I _{PN}	2.93 × I _{PN}	3.22 × I _{PN}	Peak value ±10 %, overcurrent detection OCD
Accuracy @ $I_{\rm PN}$	X	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-1		1	
Accuracy @ I_{PN} @ T_A = +105 °C	Х	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-4.55		4.55	See formula note 2)
Accuracy @ I_{PN} @ T_A = +85 °C	X	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-3.66		3.66	See formula note 2)

Notes: 1) EEPROM in an error state makes the transducer behave like a reverse current saturation. Use of the OCD may help to differentiate the two cases.

Accuracy @ T_A (% of I_{PN}) = $X + (\frac{TCG}{10000} \times (T_A - 25) + \frac{TCI_{OE}}{10000 \times I_{PN}} \times 100 \times (T_A - 25))$.



Electrical data HO 150-S/SP30-0100

At $T_{\rm A}$ = 25 °C, $U_{\rm C}$ = +5 V, $R_{\rm L}$ = 10 k Ω unless otherwise noted (see Min, Max, typ. definition paragraph in page 12).

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal RMS current	I_{PN}	А		150		
Primary current, measuring range	$I_{\scriptscriptstyle{PM}}$	А	-375		375	@ U _C ≥ 4.6 V
Number of primary turns	N _P	-		1		See application information
Supply voltage	U _c	V	4.5	5	5.5	
Current consumption	$I_{\scriptscriptstyle m C}$	mA		19	25	
Reference voltage (output)	V_{ref}	V	2.48	2.5	2.52	Internal reference
Reference voltage (input)	V_{ref}	V	0.5		2.65	External reference
Output voltage range @ $I_{\scriptscriptstyle{\mathrm{PM}}}$	V _{out} - V _{ref}	V	-2		2	Over operating temperature range
V _{ref} output resistance	R_{ref}	Ω	130	200	300	Series
V _{out} output resistance	R _{out}	Ω		2	5	Series
Allowed capacitive load	C _L	nF	0		6	
Overcurrent detection output on resistance	R _{on}	Ω	70	95	150	Open drain, active low Over operating temperature range
Overcurrent detection hold	t_{hold}	ms	0.7	1	1.4	Additional time after threshold has released
EEPROM control	$V_{ m out}$	mV	0		50	V _{out} forced to GND when EEPROM in an error state ¹⁾
Electrical offset voltage @ I_P = 0 A	V _{OE}	mV	-5		5	$V_{\text{out}} - V_{\text{ref}} @ V_{\text{ref}} = 2.5 \text{ V}$
Electrical offset current referred to primary	I_{OE}	Α	-0.94		0.94	
Temperature coefficient of V_{ref}	TCV _{ref}	ppm/K	-170		170	−40 °C 105 °C
Temperature coefficient of $V_{\text{\tiny OE}}$	TCV _{OE}	mV/K	-0.075		0.075	−40 °C 105 °C
Offset drift referred to primary \bigcirc $I_p = 0$ A	TCI _{OE}	mA/K	-14.1		14.1	-40 °C 105 °C
Theoretical sensitivity	$G_{_{ m th}}$	mV/A		5.333		800 mV @ I _{PN}
Sensitivity error @ $I_{\rm PN}$	$\boldsymbol{\varepsilon}_{_{\mathrm{G}}}$	%	-0.5		0.5	Factory adjustment (straight bus-bar)
Temperature coefficient of G	TCG	ppm/K	-350		350	−40 °C 105 °C
Linearity error 0 $I_{\rm PN}$	\mathcal{E}_{L}	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-0.5		0.5	
Linearity error 0 $I_{\rm PM}$	\mathcal{E}_{L}	% of $I_{\scriptscriptstyle{\mathrm{PM}}}$	-0.5		0.5	
Magnetic offset current (@ 10 × $I_{\rm PN}$) referred to primary	I_{OM}	А	-0.92		0.92	One turn
Reaction time @ 10 % of $I_{\scriptscriptstyle \mathrm{PN}}$	t _{ra}	μs			2.5	@ 50 A/µs
Response time @ 90 % of $I_{\rm PN}$	t _r	μs			3.5	@ 50 A/µs
Frequency bandwidth (-3 dB)	BW	kHz		100		Small signals
Output RMS noise voltage spectral density (100 Hz 100 kHz)	e _{no}	μV/√ Hz			4.5	
Output noise voltage (DC 10 kHz) (DC 100 kHz) (DC 1 MHz)	V _{no}	mVpp		2.9 6.2 12.3		
Primary current, detection threshold	$I_{ m PTh}$	Α	2.64 × I _{PN}	2.93 × I _{PN}	3.22 × I _{PN}	Peak value ±10 %, overcurrent detection OCD
Accuracy @ I _{PN}	X	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-1		1	
Accuracy @ I_{PN} @ T_{A} = +105 °C	X	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-4.55		4.55	See formula note 2)
Accuracy @ I_{PN} @ T_A = +85 °C	Х	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-3.66		3.66	See formula note 2)

Notes: 1) EEPROM in an error state makes the transducer behave like a reverse current saturation. Use of the OCD may help to differentiate the two cases.

differentiate the two cases ²⁾ Accuracy @ T_A (% of I_{PN}) = X + ($\frac{TCG}{10000}$ × (T_A -25) + $\frac{TCI_{OE}}{1000 \times I_{PN}}$ × 100 × (T_A -25)).



Electrical data HO 200-S/SP30-0100

 Δ t T_A = 25 °C, U_C = +5 V, R_L = 10 kΩ unless otherwise noted (see Min, Max, typ. definition paragraph in page 12).

Primary nominal RMS current I Images of the primary current, measuring range I Images of the primary current, measuring ranges I Images of the primary current, measuring ranges <th>Parameter</th> <th>Symbol</th> <th>Unit</th> <th>Min</th> <th>Тур</th> <th>Max</th> <th>Comment</th>	Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary current, measuring range I_{max} A -500 500 $U_c 2.4.6 \text{ V}$ Number of primary turns N_e - - 1 See application information Supply voltage U_c V 4.5 5.5 5.5 5.5 Current consumption I_c mA - 19 25 Internal reference Reference voltage (input) V_{uv} V 2.48 2.5 2.52 Internal reference Output voltage range @ I_{rec} $V_{uv} - V_{uv}$ V -2 2 Over operating temperature range V_{uv} output resistance R_{uv} Ω 130 200 300 Series Allowed capacitive load C_c nF 0 6 Current certain reference Overcurrent detection hold I_{total} I_{total} I_{total} I_{total} I_{total} EEPROM control I_{total} I_{total} I_{total} I_{total} I_{total} Electrical offset current I_{total}				1		max	Commone
	•			-500	200	500	@ U > 4 6 V
Supply voltage U_{c} V 4.5 5 5.5 Current consumption Lower consumption I_{c} mA 19 25 New Control Consumption Reference voltage (cuput) V_{vit} V 2.48 2.5 2.25 External reference Output voltage range @ I_{mu} V_{vit} V 0.5 -2 2 Over operating temperature range V_{vit} output resistance R_{mi} 0 130 200 300 Series Allowed capacitive load C_{c} nFF 0 1 6 Series Overcurrent detection output on resistance R_{mi} 0 70 95 150 Open drain, active low coversistations EEPROM control I_{max} mS 0.7 1 1.4 Additional time after threshold has released Electrical offset voltage @ I_{xy} = 0 A V_{mi} mV 0 5 V_{mi} of the prelimity in a nervo state in the released of the prelimity in a nervo state in the released of the prelimity in a nervo state in the released of the prelimity in a nervo state in the prelimity in a nervo state	, ,	1	^	-500	4	300	
Current consumption I_c mA 19 25 Internal reference Reference voltage (output) V_{vi} V 2.48 2.5 2.25 Internal reference Reference voltage (input) V_{vi} V 0.5 2.65 External reference Output voltage range @ I_{vii} V_{vii} V 0.2 2 Over operating temperature range V_{vij} output resistance R_{vij} 0 130 200 300 Series Allowed capacitive load C _C nF 0 6 Poper drain, active low Overcurrent detection output on resistance R_{vii} 0 70 95 150 Open drain, active low EEPROM control V_{vii} mV 0 -1 1,4 Additional time after threshold has released EEE clarical offset voltage @ I_y = 0 A V_{vii} mV -5 5 V_{vii} evoid only in marker late threshold has released on the proper during temperature range. Electrical offset current refered to primary I_{vii} mV -5 5	. ,	 	-	4.5			See application information
Reference voltage (output) V_{str}^{st} V 2.48 2.5 2.52 Internal reference Reference voltage (input) V_{val}^{st} V 0.5 2.65 External reference Output voltage range @ I_{sus} $V_{val}^{st} = V_{val}^{st}$ 0 130 200 300 Series V_{uo} output resistance R_{val}^{st} 0 130 20 300 Series Allowed capacitive load C_{c} nF 0 6 6 Overcurrent detection output on resistance R_{val}^{st} 0 70 95 150 Open drain, active low over operating temperature range Overcurrent detection hold t_{radd}^{st} mV 0				4.5			
Reference voltage (input) V_{var}' V 0.5 2.85 External reference Output voltage range @ I_{ran} $V_{var}'' V_{var}''$ V -2 V 2 Over operating temperature range V_{var}'' output resistance R_{var}'' 0 130 200 300 Series Allowed capacitive load C_{c} nF 0 6 0 Open drain, active low estistance R_{var} Ω 70 95 150 Open drain, active low estistance R_{var} Ω 70 95 150 Open drain, active low estistance R_{var} Ω Ω Ω Ω Open drain, active low estistance N_{var} Ω </td <td><u> </u></td> <td>î</td> <td>ļ</td> <td>0.40</td> <td></td> <td></td> <td></td>	<u> </u>	î	ļ	0.40			
	3 () ,	i			2.5		
V_{vol} output resistance R_{vol} Q 130 200 300 Series Allowed capacitive load R_{vol} Q 2 5 Series Allowed capacitive load C_i nF 0 6 6 Overcurrent detection output on resistance R_{vol} Ω 70 95 150 Open drain, active low Over operating temperature range Overcurrent detection hold I_{vol} mS 0.7 1 1.4 Additional time after threshold has released EEPROM control V_{vol} mV 0 50 I_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced to GND when EEPROM in a reversate V_{vol} forced t	•	i e		 			
V_{cot} output resistance R_{cot} Ω		1		-			Over operating temperature range
Allowed capacitive load C_i nF 0 6	101			130		-	Series
Overcurrent detection output on resistance R_{∞} Ω 70 95 150 Open drain, active low Over operating temperature range Overcurrent detection hold t_{hold} ms 0.7 1 1.4 Additional time after threshold has released EEPROM control V_{out} mV 0 50 V_{out} forced to GNb when EEPROM released Electrical offset voltage @ $I_{\nu} = 0$ A V_{∞} mV -5 50 V_{out} Orcate to GNb when EEPROM released in an error state 10 Electrical offset uotinge @ $I_{\nu} = 0.0$ I_{∞} mV -5 5 $V_{\text{out}} \sim V_{\text{out}} \otimes V_{\text{out}} = 2.5 \text{V}$ Electrical offset current relations of the primary referred to primary I_{∞}	001	î			2	5	Series
resistance N_{co} Ω N_{co} <	Allowed capacitive load	C _L	nF	0		6	
Second control Contro	·	R _{on}	Ω	70	95	150	
Electrical offset voltage @ $I_{\rm p} = 0.4$ $V_{\rm OE}$ $V_{\rm OE}$ $V_{\rm OE}$ $V_{\rm oet} - V_{\rm rec}$ @ $V_{\rm eet} = 2.5 {\rm V}$ Electrical offset current referred to primary $I_{\rm CE}$	Overcurrent detection hold	t_{hold}	ms	0.7	1	1.4	
Electrical offset current referred to primary I_{OE} A I_{OE} I_{OE	EEPROM control	$V_{ m out}$	mV	0		50	V _{out} forced to GND when EEPROM in an error state ¹⁾
referred to primary I_{OE} A -1.25 1.25 Temperature coefficient of V_{ref} TCV_{ref} ppm/K -170 170 -40 °C 105 °C Offset drift referred to primary $Q_{I_{PN}}$ TCI_{OE} mV/K -0.075 0.075 -40 °C 105 °C Offset drift referred to primary $Q_{I_{PN}}$ TCI_{OE} mA/K -18.75 18.75 -40 °C 105 °C Theoretical sensitivity G_{in} mV/A 4 800 mV @ I_{PN} Sensitivity error @ I_{PN} \mathcal{E}_{G} % -0.5 0.5 Factory adjustment (straight bus-bar) Temperature coefficient of G TCG ppm/K -350 350 -40 °C 105 °C Linearity error 0 I_{PN} \mathcal{E}_{G} % of I_{PN} -0.5 0.5 Linearity error 0 I_{PN} I_{CM} A -0.92 0.92 One turn Reaction time @ 10 % of I_{PN} I_{A} I_{A} I_{A} I_{A} I_{A} Response time @ 90 % of I_{A} I_{A}	Electrical offset voltage @ $I_{\rm p}$ = 0 A	V _{OE}	mV	-5		5	$V_{\text{out}} - V_{\text{ref}} @ V_{\text{ref}} = 2.5 \text{ V}$
Temperature coefficient of $V_{\rm ce}$ $TCV_{\rm ce}$ mV/K -0.075 0.075 $-40^{\circ}{\rm C}\dots 105^{\circ}{\rm C}$ Offset drift referred to primary 0 $I_{\rm p} = 0$ A $TCI_{\rm og}$ 0 $I_{\rm p} = 0$ A $TCI_{\rm og}$ 0 $I_{\rm p} = 0$ A $I_{\rm og}$		I_{OE}	А	-1.25		1.25	
Offset drift referred to primary $@I_{P_p} = 0 \text{A}$ TCI_{OE} mA/K -18.75 18.75 $-40 ^{\circ}\text{C} \dots 105 ^{\circ}\text{C}$ Theoretical sensitivity G_{m} mV/A 4 800 mV @ I_{pN} Sensitivity error @ I_{PN} ε_{G} % -0.5 0.5 Factory adjustment (straight bus-bar) Temperature coefficient of G TCG ppm/K -350 350 $-40 ^{\circ}\text{C} \dots 105 ^{\circ}\text{C}$ Linearity error $0 \dots I_{\text{PN}}$ ε_{L} % of I_{PN} -0.5 0.5 Linearity error $0 \dots I_{\text{PN}}$ ε_{L} % of I_{PN} -0.5 0.5 Linearity error $0 \dots I_{\text{PN}}$ ε_{L} % of I_{PN} -0.5 0.5 Linearity error $0 \dots I_{\text{PN}}$ ε_{L} % of I_{PN} -0.5 0.5 Magnetic offset current (@ $10 \times I_{\text{PN}}$) I_{OM} A -0.92 0.92 One turn Reaction time @ 10% of I_{PN} I_{N} I_{N} I_{N} I_{N} I_{N} I_{N} I_{N} I_{N} I_{N}	Temperature coefficient of $V_{\rm ref}$	TCV _{ref}	ppm/K	-170		170	−40 °C 105 °C
Theoretical sensitivity $G_{\rm p}$ mV/A A 800 mV @ $I_{\rm pN}$ Sensitivity error @ $I_{\rm PN}$ $\varepsilon_{\rm G}$ % A -0.5 A 0.5 Factory adjustment (straight bus-bar) (st	Temperature coefficient of V_{OE}	TCV _{OE}	mV/K	-0.075		0.075	−40 °C 105 °C
Sensitivity error @ I_{PN} ε_G % -0.5 0.5 Factory adjustment (straight bus-bar) Temperature coefficient of G TCG ppm/K -350 350 $-40 ^{\circ} \text{C} \dots 105 ^{\circ} \text{C}$ Linearity error $0 \dots I_{PN}$ ε_L % of I_{PN} -0.5 0.5 Linearity error $0 \dots I_{PM}$ ε_L % of I_{PM} -0.5 0.5 Magnetic offset current (@10 × I_{PN}) I_{OM} A -0.92 0.92 One turn Reaction time @ 10 % of I_{PN} I_{OM} A -0.92 0.92 One turn Response time @ 90 % of I_{PN} I_{OM} I		TCI _{OE}	mA/K	-18.75		18.75	-40 °C 105 °C
Sensitivity error @ I_{PN} \mathcal{E}_G 70 -0.5 0.5 (straight bus-bar) Temperature coefficient of G TCG ppm/K -350 350 $-40 ^{\circ}C \dots 105 ^{\circ}C$ Linearity error $0 \dots I_{PN}$ \mathcal{E}_L % of I_{PN} -0.5 0.5 Linearity error $0 \dots I_{PM}$ \mathcal{E}_L % of I_{PN} -0.5 0.5 Magnetic offset current (@10 × I_{PN}) I_{OM} A -0.92 0.92 One turn Reaction time @ 10 % of I_{PN} I_{TN}	Theoretical sensitivity	G _{th}	mV/A		4		800 mV @ I _{PN}
Linearity error $0 \dots I_{PN}$ ε_{L} % of I_{PN} -0.5 0.5 Linearity error $0 \dots I_{PM}$ ε_{L} % of I_{PM} -0.5 0.5 Magnetic offset current (@10 × I_{PN}) I_{OM} A -0.92 0.92 One turn Reaction time @ 10 % of I_{PN} $I_{I_{RM}}$ $\mu_{I_{RM}}$ 2.5 @ 50 A/ $\mu_{I_{RM}}$ Response time @ 90 % of I_{PN} $I_{I_{RM}}$ $I_{I_{RM}}$ $I_{I_{RM}}$ $I_{I_{RM}}$ $I_{I_{RM}}$ Frequency bandwidth (-3 dB) $I_{I_{RM}}$	Sensitivity error @ $I_{\rm PN}$	$\boldsymbol{\mathcal{E}}_{G}$	%	-0.5		0.5	
Linearity error $0 \dots I_{PM}$ \mathcal{E}_{L} % of I_{PM} -0.5 0.5 Magnetic offset current (@10 × I_{PN}) referred to primary I_{OM} A -0.92 0.92 One turn Reaction time @ 10 % of I_{PN} I_{Ta} μ s 2.5 @ 50 A/ μ s Response time @ 90 % of I_{PN} I_{Ta} μ s 100 3.5 @ 50 A/ μ s Frequency bandwidth (-3 dB) BW kHz 100 3.7 Small signals Output RMS noise voltage spectral density (100 Hz 100 kHz) e_{no} μ V/ \sqrt{Hz} 3.7 3.7 3.7 Output noise voltage (DC 10 kHz) (DC 10 kHz) (DC 140 k	Temperature coefficient of G	TCG	ppm/K	-350		350	−40 °C 105 °C
Linearity error $0 \dots I_{PM}$ \mathcal{E}_{L} % of I_{PM} -0.5 0.5 Magnetic offset current (@10 × I_{PN}) referred to primary I_{OM} A -0.92 0.92 One turn Reaction time @ 10 % of I_{PN} I_{Ta} μ s 2.5 @ 50 A/ μ s Response time @ 90 % of I_{PN} I_{Ta} μ s 100 3.5 @ 50 A/ μ s Frequency bandwidth (-3 dB) BW kHz 100 3.7 Small signals Output RMS noise voltage spectral density (100 Hz 100 kHz) e_{no} μ V/ \sqrt{Hz} 3.7 3.7 3.7 Output noise voltage (DC 10 kHz) (DC 10 kHz) (DC 140 k	Linearity error $0 \dots I_{\scriptscriptstyle \mathrm{PN}}$	ε,	% of $I_{\scriptscriptstyle \mathrm{DN}}$	-0.5		0.5	
Magnetic offset current (@10 × I_{PN}) I_{OM} A -0.92 0.92 One turn Reaction time @ 10 % of I_{PN} t_{ra} μs 2.5 @ 50 A/μs Response time @ 90 % of I_{PN} t_r μs 3.5 @ 50 A/μs Frequency bandwidth (-3 dB) BW kHz 100 Small signals Output RMS noise voltage spectral density (100 Hz 100 kHz) e_{no} μ V/νHz 3.7 3.7 Output noise voltage (DC 10 kHz) (DC 10 kHz) (DC 14 MHz) V_{no} m Vpp v 0 v 0<		1		-0.5		0.5	
Reaction time @ 10 % of I_{PN} t_{ra} μs 2.5 @ 50 A/ μs Response time @ 90 % of I_{PN} t_r μs 3.5 @ 50 A/ μs Frequency bandwidth (-3 dB) BW kHz 100 Small signals Output RMS noise voltage spectral density (100 Hz 100 kHz) e_{no} $\mu V / V Hz$ 3.7 Output noise voltage (DC 10 kHz) (DC 10 kHz) (DC 10 kHz) (DC 100 kHz) (DC 100 kHz) (DC 100 kHz) $m V pp$ 2.5 5 5 10 kHz (DC 1 MHz) A 2.64 × I_{PN} 2.93 × I_{PN} 3.22 × I_{PN} Peak value ±10 %, overcurrent detection OCD Accuracy @ I_{PN} X % of I_{PN} -1 1 Accuracy @ I_{PN} @ T_A = +105 °C X % of I_{PN} -4.55 See formula note 2)	Magnetic offset current (@10 × I_{PN})	İ		-0.92		0.92	One turn
Response time @ 90 % of I_{PN} t_r μs 3.5 @ 50 A/μs Frequency bandwidth (-3 dB) BW kHz 100 Small signals Output RMS noise voltage spectral density (100 Hz 100 kHz) e_{no} μ V/ \sqrt{Hz} 3.7 Output noise voltage (DC 10 kHz) (DC 10 kHz) (DC 100 kHz) (DC 14 MHz) v_{no}	· · ·	t	μs			2.5	@ 50 A/µs
Frequency bandwidth (-3 dB) BW kHz 100 Small signals Output RMS noise voltage spectral density (100 Hz 100 kHz) e_{no} μ V/ \sqrt{Hz} 3.7 Output noise voltage (DC 10 kHz) V_{no} m Vpp 2.5 5 10 Primary current, detection threshold I_{PTh} A $2.64 \times I_{PN}$ $2.93 \times I_{PN}$ $3.22 \times I_{PN}$ Peak value ± 10 %, overcurrent detection OCD Accuracy @ I_{PN} X % of I_{PN} -1 1 Accuracy @ I_{PN} @ T_A = ± 105 °C X % of I_{PN} -4.55 See formula note ± 100 Small signals 3.7							
Output RMS noise voltage spectral density (100 Hz 100 kHz)					100		
	Output RMS noise voltage spectral					3.7	
Accuracy @ I_{PN}	(DC 10 kHz) (DC 100 kHz)	V _{no}	mVpp		5		
Accuracy @ I_{PN} @ T_A = +105 °C	Primary current, detection threshold	I_{PTh}	А	2.64 × I _{PN}	2.93 × I _{PN}	3.22 × I _{PN}	
	Accuracy @ I_{PN}	X	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-1		1	
	Accuracy @ I_{PN} @ T_{A} = +105 °C	X	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-4.55		4.55	See formula note 2)
	Accuracy @ I_{PN} @ T_A = +85 °C	Х	% of $I_{\scriptscriptstyle{PN}}$	-3.66		3.66	See formula note 2)

Notes: 1) EEPROM in an error state makes the transducer behave like a reverse current saturation. Use of the OCD may help to differentiate the two cases.

differentiate the two cases

2) Accuracy @ T_A (% of I_{PN}) = X + ($\frac{TCG}{10000}$ × (T_A -25) + $\frac{TCI_{OE}}{1000 \times I_{PN}}$ × 100 × (T_A -25)).



Electrical data HO 200-S/SP31-1100

At $T_{\rm A}$ = 25 °C, $U_{\rm C}$ = +5 V, $R_{\rm L}$ = 10 k Ω unless otherwise noted (see Min, Max, typ. definition paragraph in page 12).

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal RMS current	I_{PN}	Α		200		
Primary current, measuring range	I_{PM}	A	-388		500	@ U _c ≥ 4.6 V
Number of primary turns	N _P	-		1		See application information
Supply voltage	U _c	V	4.5	5	5.5	Состинения положения
Current consumption	I _C	mA	1	19	25	
Reference voltage (output)	V _{ref}	V	1.63	1.65	1.67	Internal reference
Reference voltage (input)	V _{ref}	V	0.5		2.65	External reference
Output voltage range @ $I_{\rm PM}$	V _{out} - V _{ref}	V	-1.55		2	Over operating temperature range
V _{ref} output resistance	R _{ref}	Ω	130	200	300	Series
V _{out} output resistance	R _{out}	Ω		2	5	Series
Allowed capacitive load	C _L	nF	0		6	
Overcurrent detection output on resistance	R _{on}	Ω	70	95	150	Open drain, active low Over operating temperature range
Overcurrent detection hold	t_{hold}	ms	0.7	1	1.4	Additional time after threshold has released
EEPROM control	$V_{ m out}$	mV	0		50	V _{out} forced to GND when EEPROM in an error state ¹⁾
Electrical offset voltage @ I_P = 0 A	V _{OE}	mV	-5		5	$V_{\text{out}} - V_{\text{ref}} @ V_{\text{ref}} = 1.65 \text{ V}$
Electrical offset current referred to primary	$I_{\scriptscriptstyle{OE}}$	Α	-1.25		1.25	
Temperature coefficient of V_{ref}	TCV _{ref}	ppm/K	-170		170	−40 °C 105 °C
Temperature coefficient of V_{OE}	TCV _{OE}	mV/K	-0.075		0.075	−40 °C 105 °C
Offset drift referred to primary @ $I_p = 0$ A	TCI _{OE}	mA/K	-18.75		18.75	−40 °C 105 °C
Theoretical sensitivity	G_{th}	mV/A		4		800 mV @ I _{PN}
Sensitivity error @ $I_{\scriptscriptstyle \mathrm{PN}}$	ε _G	%	-0.5		0.5	Factory adjustment (straight bus-bar)
Temperature coefficient of G	TCG	ppm/K	-350		350	−40 °C 105 °C
Linearity error 0 \dots $I_{\scriptscriptstyle{\mathrm{PN}}}$	$\mathcal{E}_{_{oldsymbol{oldsymbol{arepsilon}}}$	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-0.5		0.5	
Linearity error 0 $I_{\scriptscriptstyle{\mathrm{PM}}}$	\mathcal{E}_{L}	% of $I_{\scriptscriptstyle{\mathrm{PM}}}$	-0.5		0.5	
Magnetic offset current (@10 × $I_{\rm PN}$) referred to primary	$I_{\scriptscriptstyle{OM}}$	Α	-0.92		0.92	One turn
Reaction time @ 10 % of $I_{\scriptscriptstyle{\mathrm{PN}}}$	t _{ra}	μs			2.5	@ 50 A/µs
Response time @ 90 % of $I_{\scriptscriptstyle{\mathrm{PN}}}$	t _r	μs			3.5	@ 50 A/µs
Frequency bandwidth (-3 dB)	BW	kHz		100		Small signals
Output RMS noise voltage spectral density (100 Hz 100 kHz)	e _{no}	μV/√ Hz			3.7	
Output noise voltage (DC 10 kHz) (DC 100 kHz) (DC 1 MHz)	V _{no}	mVpp		2.5 5 10		
Primary current, detection threshold	I_{PTh}	Α	2.64 × I _{PN}	2.93 × I _{PN}	3.22 × I _{PN}	Peak value ±10 %, overcurrent detection OCD
Accuracy @ $I_{\rm PN}$	X	$\%$ of $I_{_{\mathrm{PN}}}$	-1		1	
Accuracy @ I_{PN} @ T_A = +105 °C	X	$\%$ of $I_{_{\mathrm{PN}}}$	-4.55		4.55	See formula note 2)
Accuracy @ I_{PN} @ T_A = +85 °C	X	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-3.66		3.66	See formula note 2)

Notes: 1) EEPROM in an error state makes the transducer behave like a reverse current saturation. Use of the OCD may help to

differentiate the two cases ²⁾ Accuracy @ T_A (% of I_{PN}) = X + ($\frac{TCG}{10000}$ × (T_A -25) + $\frac{TCI_{OE}}{1000 \times I_{PN}}$ × 100 × (T_A -25)).



Electrical data HO 250-S/SP30-0100

At $T_{\rm A}$ = 25 °C, $U_{\rm C}$ = +5 V, $R_{\rm L}$ = 10 k Ω unless otherwise noted (see Min, Max, typ. definition paragraph in page 12).

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal RMS current	I_{PN}	А		250		
Primary current, measuring range	$I_{\scriptscriptstyle{PM}}$	А	-625		625	@ U _c ≥ 4.6 V
Number of primary turns	N _P	-		1		See application information
Supply voltage	U _c	V	4.5	5	5.5	
Current consumption	$I_{\rm c}$	mA		19	25	
Reference voltage (output)	V_{ref}	V	2.48	2.5	2.52	Internal reference
Reference voltage (input)	V _{ref}	V	0.5		2.65	External reference
Output voltage range @ $I_{\rm PM}$	V _{out} - V _{ref}	V	-2		2	Over operating temperature range
V _{ref} output resistance	R_{ref}	Ω	130	200	300	Series
V _{out} output resistance	R _{out}	Ω		2	5	Series
Allowed capacitive load	C _L	nF	0		6	
Overcurrent detection output on resistance	R_{on}	Ω	70	95	150	Open drain, active low Over operating temperature range
Overcurrent detection hold	t_{hold}	ms	0.7	1	1.4	Additional time after threshold has released
EEPROM control	$V_{ m out}$	mV	0		50	V _{out} forced to GND when EEPROM in an error state ¹⁾
Electrical offset voltage @ I_P = 0 A	V _{OE}	mV	-5		5	$V_{\text{out}} - V_{\text{ref}} @ V_{\text{ref}} = 2.5 \text{ V}$
Electrical offset current referred to primary	$I_{\scriptscriptstyle{ m OE}}$	Α	-1.57		1.57	
Temperature coefficient of V_{ref}	TCV _{ref}	ppm/K	-170		170	−40 °C 105 °C
Temperature coefficient of $V_{\scriptscriptstyle{ m OE}}$	TCV _{OE}	mV/K	-0.075		0.075	−40 °C 105 °C
Offset drift referred to primary $@I_P = 0$ A	TCI _{OE}	mA/K	-23.5		23.5	−40 °C 105 °C
Theoretical sensitivity	G_{th}	mV/A		3.2		800 mV@ $I_{\rm PN}$
Sensitivity error @ $I_{\rm PN}$	$oldsymbol{arepsilon}_{G}$	%	-0.5		0.5	Factory adjustment (straight bus-bar)
Temperature coefficient of G	TCG	ppm/K	-350		350	−40 °C 105 °C
Linearity error 0 \dots $I_{\rm PN}$	\mathcal{E}_{L}	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-0.5		0.5	
Linearity error 0 $I_{\scriptscriptstyle{\mathrm{PM}}}$	\mathcal{E}_{L}	% of $I_{\scriptscriptstyle{\mathrm{PM}}}$	-0.5		0.5	
Magnetic offset current (@ 10 × $I_{\rm PN}$) referred to primary	I_{OM}	А	-0.92		0.92	One turn
Reaction time @ 10 % of $I_{\scriptscriptstyle{\mathrm{PN}}}$	t _{ra}	μs			2.5	@ 50 A/µs
Response time @ 90 % of $I_{\rm PN}$	t _r	μs			3.5	@ 50 A/µs
Frequency bandwidth (-3 dB)	BW	kHz		100		Small signals
Output RMS noise voltage spectral density (100 Hz100 kHz)	e _{no}	μV/√Hz			3.5	
Output noise voltage (DC 10 kHz) (DC 100 kHz) (DC 1 MHz)	V _{no}	mVpp		2.5 5 8.7		
Primary current, detection threshold	$I_{ extsf{PTh}}$	А	2.64 × I _{PN}	2.93 × I _{PN}	3.22 × I _{PN}	Peak value ±10 %, overcurrent detection OCD
Accuracy @ $I_{\scriptscriptstyle{\mathrm{PN}}}$	Х	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-1		1	
Accuracy @ I_{PN} @ T_A = +105 °C	Х	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-4.55		4.55	See formula note 2)
Accuracy @ I_{PN} @ T_A = +85 °C	Х	% of $I_{\scriptscriptstyle{\mathrm{PN}}}$	-3.66		3.66	See formula note 2)

Notes: 1) EEPROM in an error state makes the transducer behave like a reverse current saturation. Use of the OCD may help to differentiate the two cases

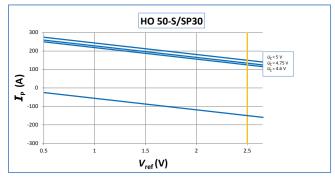
differentiate the two cases

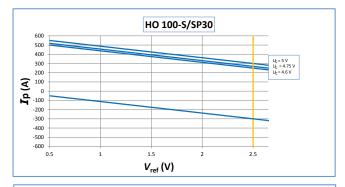
2) Accuracy @ T_A (% of I_{PN}) = $X + (\frac{TCG}{10000} \times (T_A - 25) + \frac{TCI_{OE}}{1000 \times I_{PN}} \times 100 \times (T_A - 25))$.

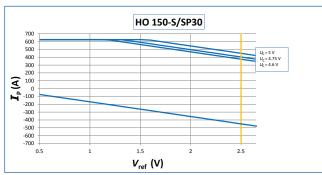


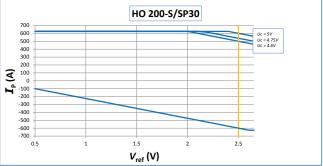


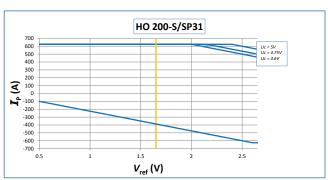
HO-S/SP30 series and HO 200-S/SP31, measuring range versus external reference voltage

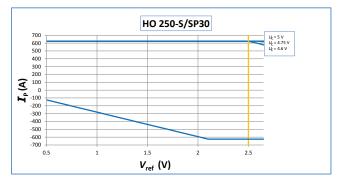








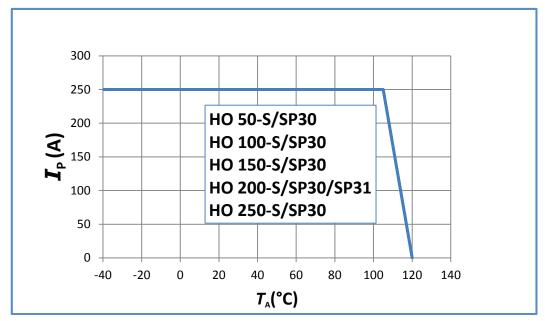






Maximum continuous DC current

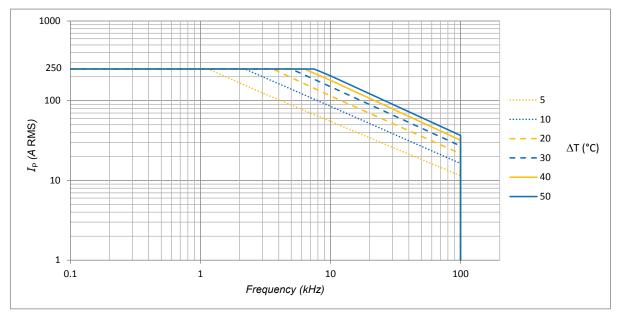
For all ranges:



Important notice: whatever the usage and/or application, the transducer primary bar temperature shall not go above the maximum rating of 120 °C as stated in page 2 of this datasheet.

Frequency derating versus primary current and core temperature increase ΔT (°C)

Primary current in A RMS is sine wave.



Example:

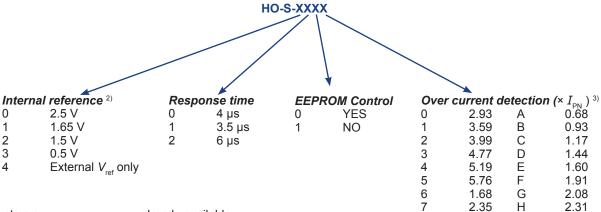
Primary current ripple (sine wave): 50 A RMS Ripple frequency: 20 kHz

- the core temperature increase is 10 °C.



HO-S series: name and codification

HO family products may be ordered *on request* ¹⁾ with a dedicated setting of the parameters as described below (standard products are delivered with the setting 0100 according to the table).



SP products are:

- HO 50-S/SP30-0100

- HO 100-S/SP30-0100

- HO 150-S/SP30-0100

- HO 200-S/SP30-0100

- HO 250-S/SP30-0100

Notes: 1) For dedicated settings, minimum quantities apply, please contact your local LEM support.

already available:

HO 200-S/SP31-1100

 $^{^{2)}}$ $V_{\rm ref}$ electrical data

$V_{ m ref}$		$V_{\rm ref}$ (V)	TCV _{ref} (ppm/K)	
parameter	min	typ	max	min	max
0	2.48	2.5	2.52	-170	-70
1	1.63	1.65	1.67	-170	170
2	1.48	1.5	1.52	-170	170
3	0.49	0.5	0.51	-250	250

 $^{^{\}rm 3)}$ OCD (× $I_{\rm PN}$) correction table versus range and temperature All other values or empty cells: no change

HO-S/SP30-010x HO-S/SP31-110x									
OCD	$I_{\scriptscriptstyle{PN}}$ (A) a	III tempe	ratures						
Parameter	150	200	250						
Α									
В									
С									
D									
E									
6									
F									
G									
Н									
7									
0									
1									
2									
3			5.60						
4			7.30						
5		6.25	-						

Tolerance on OCD value		
±20 %		
±15 %		
±10 %	No change	
-	Do not use	



Application information

- HOxx-S series is designed to be used with a bus-bar or a cable ¹⁾ to carry the current through the aperture with a maximum cross-section of 8 × 15 mm
- Use of a bare conductor is not recommended with panel mounting (either horizontal or vertical) as insulation distances might be compromised between the busbar and fixation screws.

Insulation distance (nominal values):

	d _{Cp}	d _{CI}
Between primary busbar and secondary pin	14.6 mm	-
Between primary busbar and core	-	11.34 mm
Between core and secondary terminal	-	1.18 mm

Note: 1) The maximum magnetic offset referred to primary is inversely proportional to the number of turns, thus is divided by 2 with 2 turns

Definition of typical, minimum and maximum values

Minimum and maximum values for specified limiting and safety conditions have to be understood as such as well as values shown in "typical" graphs.

On the other hand, measured values are part of a statistical distribution that can be specified by an interval with upper and lower limits and a probability for measured values to lie within this interval.

Unless otherwise stated (e.g. "100 % tested"), the LEM definition for such intervals designated with "min" and "max" is that the probability for values of samples to lie in this interval is 99.73 %.

For a normal (Gaussian) distribution, this corresponds to an interval between -3 sigma and +3 sigma. If "typical" values are not obviously mean or average values, those values are defined to delimit intervals with a probability of 68.27 %, corresponding to an interval between -sigma and +sigma for a normal distribution.

Typical, maximal and minimal values are determined during the initial characterization of the product.

Remark

Installation of the transducer must be done unless otherwise specified on the datasheet, according to LEM Transducer Generic Mounting Rules. Please refer to LEM document N°ANE120504 available on our Web site: **Products/Product Documentation**

Safety

This transducer must be used in limited-energy secondary circuits.



This transducer must be used in electric/electronic equipment with respect to applicable standards and safety requirements in accordance with the manufacturer's operating instructions.



Caution, risk of electrical shock.

When operating the transducer, certain parts of the module can carry hazardous voltage (e.g. primary bus bar, power supply). Ignoring this warning can lead to injury and/or cause serious damage.

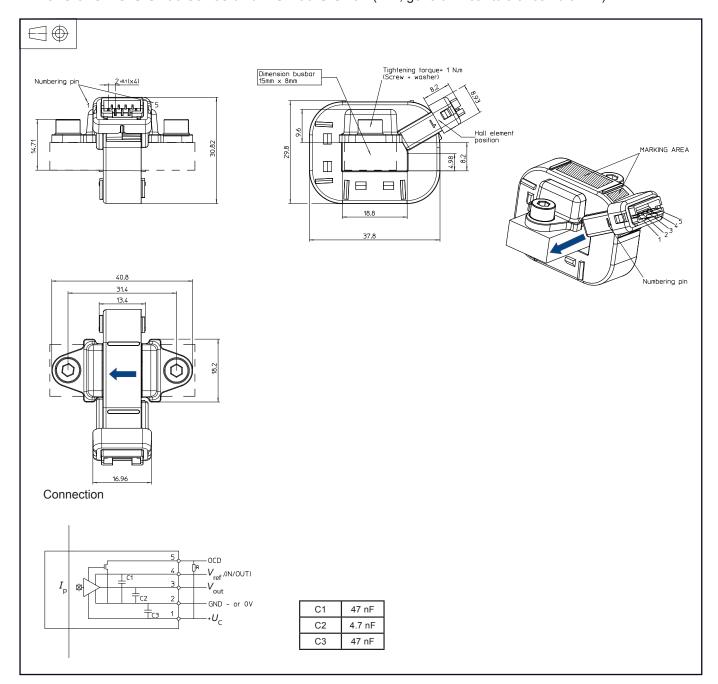
This transducer is a build-in device, whose conducting parts must be inaccessible after installation.

A protective housing or additional shield could be used.

Main supply must be able to be disconnected.



Dimensions HO-S/SP30 series and HO 200-S/SP31 (mm, general linear tolerance ±0.3 mm)



Remarks:

- V_{OUT} is positive with respect to V_{ref} when positive I_{P} flows in direction of the arrow shown on the drawing above
- Connection system: equivalent to JST B5B-PH type
- Mounting foot may be removed and repositioned as shown on pages 14, 15, 16 of the standard datasheet HO-S series.

We recommend to change the mounting foot position just once.